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Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

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Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China

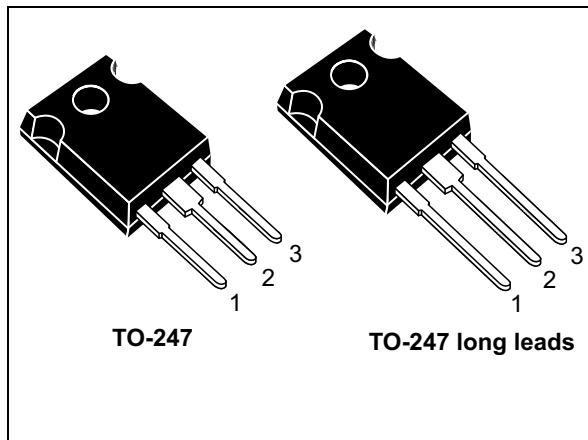
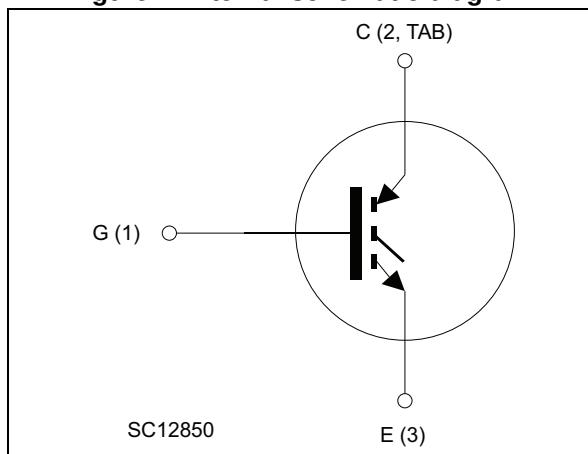


Figure 1. Internal schematic diagram



Features

- Maximum junction temperature: $T_J = 175 \text{ }^\circ\text{C}$
- High speed switching series
- Minimized tail current
- $V_{CE(\text{sat})} = 2.1 \text{ V (typ.)} @ I_C = 40 \text{ A}$
- 5 μs minimum short-circuit withstand time at $T_J = 150 \text{ }^\circ\text{C}$
- Safe paralleling
- Low thermal resistance

Applications

- Uninterruptible power supply
- Welding machines
- Photovoltaic inverters
- Power factor correction
- High frequency converters

Description

These devices are IGBTs developed using an advanced proprietary trench gate field-stop structure. These devices are part of the H series of IGBTs, which represent an optimum compromise between conduction and switching losses to maximize the efficiency of high switching frequency converters. Moreover, a slightly positive $V_{CE(\text{sat})}$ temperature coefficient and very tight parameter distribution result in safer paralleling operation.

Table 1. Device summary

Order code	Marking	Package	Packaging
STGW40H120F2	G40H120F2	TO-247	Tube
STGWA40H120F2	G40H120F2	TO-247 long leads	Tube

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1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{CES}	Collector-emitter voltage ($V_{GE} = 0$)	1200	V
I_C	Continuous collector current at $T_C = 25^\circ\text{C}$	80	A
I_C	Continuous collector current at $T_C = 100^\circ\text{C}$	40	A
$I_{CP}^{(1)}$	Pulsed collector current	160	A
V_{GE}	Gate-emitter voltage	± 20	V
P_{TOT}	Total dissipation at $T_C = 25^\circ\text{C}$	468	W
T_{STG}	Storage temperature range	-55 to 150	$^\circ\text{C}$
T_J	Operating junction temperature	-55 to 175	$^\circ\text{C}$

1. Pulse width limited by maximum junction temperature

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R_{thJC}	Thermal resistance junction-case	0.32	$^\circ\text{C}/\text{W}$
R_{thJA}	Thermal resistance junction-ambient	50	$^\circ\text{C}/\text{W}$

2 Electrical characteristics

$T_J = 25^\circ\text{C}$ unless otherwise specified.

Table 4. Static characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{CES}}$	Collector-emitter breakdown voltage ($V_{GE} = 0$)	$I_C = 2 \text{ mA}$	1200			V
$V_{CE(\text{sat})}$	Collector-emitter saturation voltage	$V_{GE} = 15 \text{ V}, I_C = 40 \text{ A}$		2.1	2.6	V
		$V_{GE} = 15 \text{ V}, I_C = 40 \text{ A}$ $T_J = 125^\circ\text{C}$		2.4		
		$V_{GE} = 15 \text{ V}, I_C = 40 \text{ A}$ $T_J = 175^\circ\text{C}$		2.5		
$V_{GE(\text{th})}$	Gate threshold voltage	$V_{CE} = V_{GE}, I_C = 2 \text{ mA}$	5	6	7	V
I_{CES}	Collector cut-off current ($V_{GE} = 0$)	$V_{CE} = 1200 \text{ V}$			25	μA
I_{GES}	Gate-emitter leakage current ($V_{CE} = 0$)	$V_{GE} = \pm 20 \text{ V}$			250	nA

Table 5. Dynamic characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{ies}	Input capacitance	$V_{CE} = 25 \text{ V}, f = 1 \text{ MHz},$ $V_{GE} = 0$	-	3200	-	pF
C_{oes}	Output capacitance		-	220	-	pF
C_{res}	Reverse transfer capacitance		-	80	-	pF
Q_g	Total gate charge	$V_{CC} = 960 \text{ V}, I_C = 40 \text{ A},$ $V_{GE} = 15 \text{ V}$, see Figure 24	-	158	-	nC
Q_{ge}	Gate-emitter charge		-	17	-	nC
Q_{gc}	Gate-collector charge		-	85	-	nC

Table 6. Switching characteristics (inductive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{CE} = 600 \text{ V}, I_C = 40 \text{ A}, R_G = 10 \Omega, V_{GE} = 15 \text{ V}$, see Figure 23		18	-	ns
t_r	Current rise time			37	-	ns
$(di/dt)_{on}$	Turn-on current slope			1755	-	A/ μs
$t_{d(off)}$	Turn-off delay time			152	-	ns
t_f	Current fall time			83	-	ns
$E_{on}^{(1)}$	Turn-on switching losses			1.0	-	mJ
$E_{off}^{(2)}$	Turn-off switching losses			1.32	-	mJ
E_{ts}	Total switching losses			2.32	-	mJ
$t_{d(on)}$	Turn-on delay time	$V_{CE} = 600 \text{ V}, I_C = 40 \text{ A}, R_G = 10 \Omega, V_{GE} = 15 \text{ V}, T_J = 175 \text{ }^\circ\text{C}$, see Figure 23		36	-	ns
t_r	Current rise time			20	-	ns
$(di/dt)_{on}$	Turn-on current slope			1580	-	A/ μs
$t_{d(off)}$	Turn-off delay time			161	-	ns
t_f	Current fall time			190	-	ns
$E_{on}^{(1)}$	Turn-on switching losses			1.81	-	mJ
$E_{off}^{(2)}$	Turn-off switching losses			2.46	-	mJ
E_{ts}	Total switching losses			4.27	-	mJ
t_{sc}	Short-circuit withstand time	$V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V}, T_J = 150 \text{ }^\circ\text{C}$,	5		-	μs

1. Energy losses include reverse recovery of the external diode. The diode is the same of the co-packed STGW40H120DF2

2. Turn-off losses include also the tail of the collector current.

2.1 Electrical characteristics (curves)

Figure 2. Power dissipation vs. case temperature

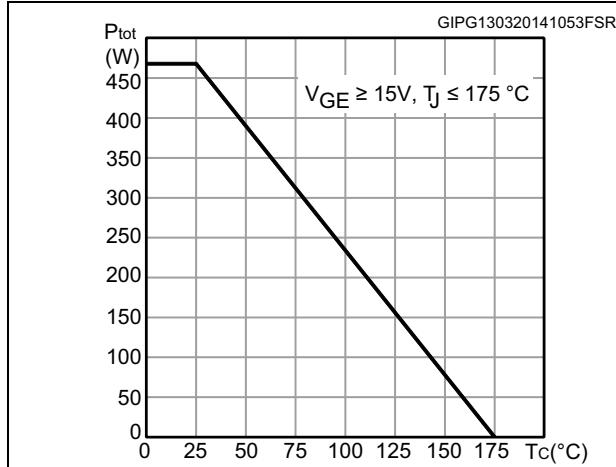


Figure 3. Collector current vs. case temperature

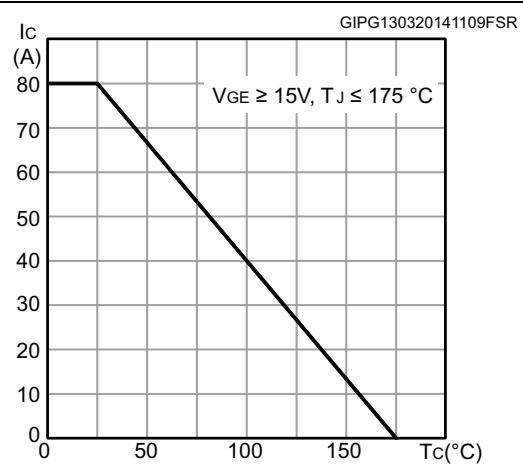


Figure 4. Output characteristics ($T_J = 25^{\circ}C$)

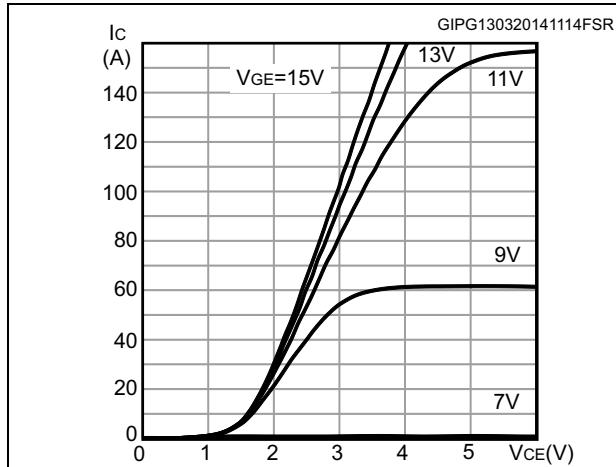


Figure 5. Output characteristics ($T_J = 175^{\circ}C$)

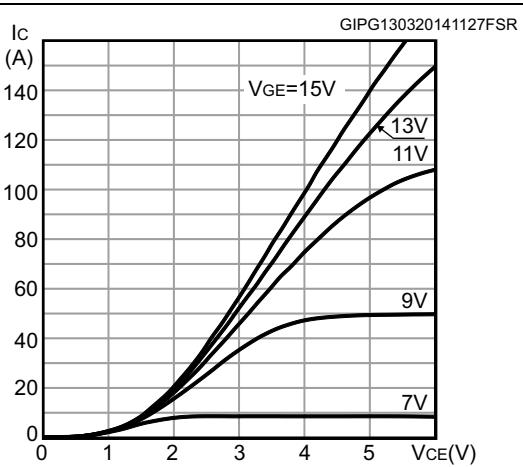


Figure 6. $V_{CE(sat)}$ vs. junction temperature

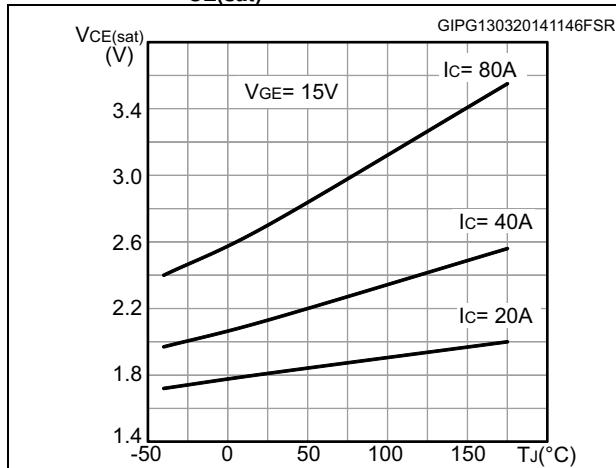


Figure 7. $V_{CE(sat)}$ vs. collector current

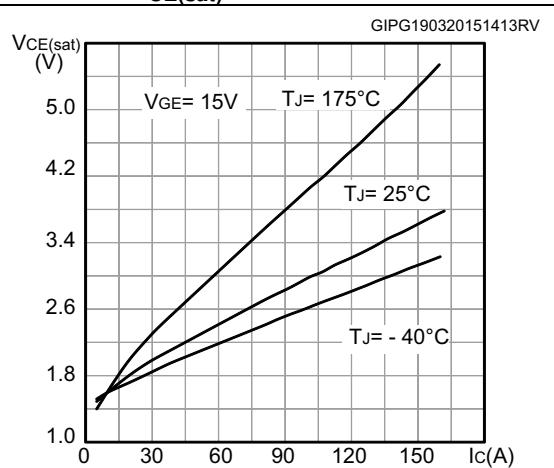


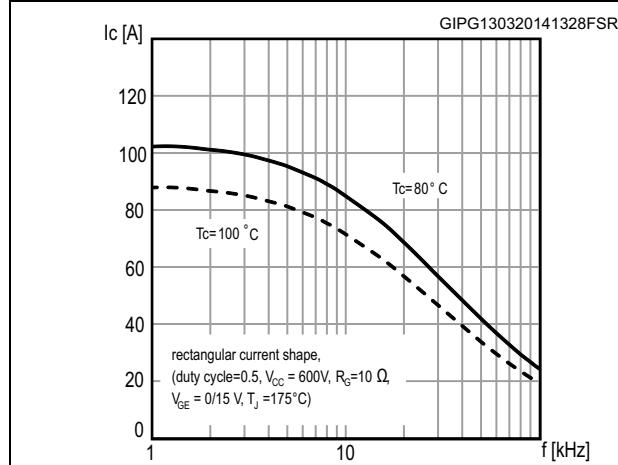
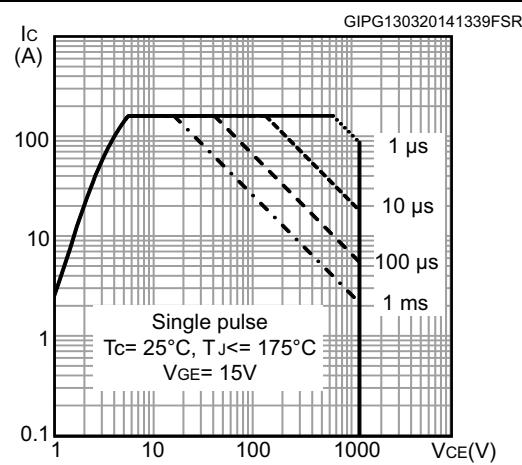
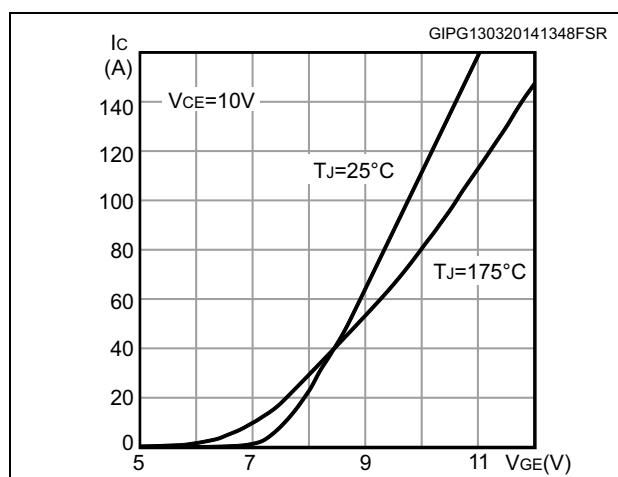
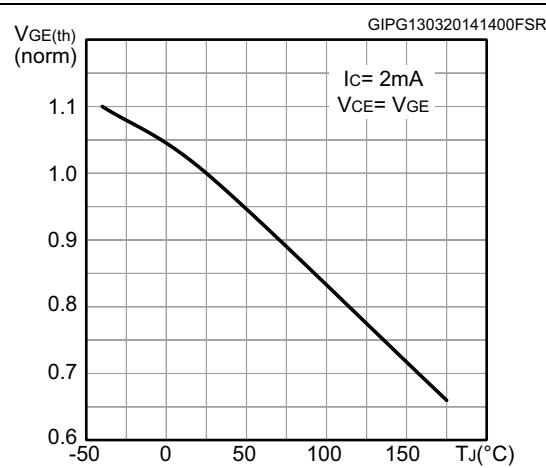
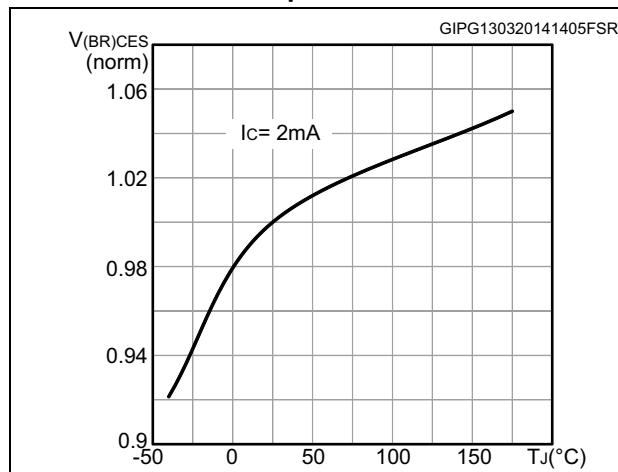
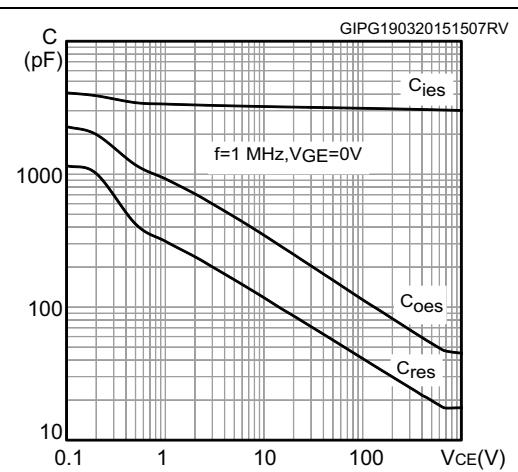
Figure 8. Collector current vs. switching frequency**Figure 9. Forward bias safe operating area****Figure 10. Transfer characteristics****Figure 11. Normalized $V_{GE(\text{th})}$ vs junction temperature****Figure 12. Normalized $V_{(BR)CES}$ vs. junction temperature****Figure 13. Capacitance variation**

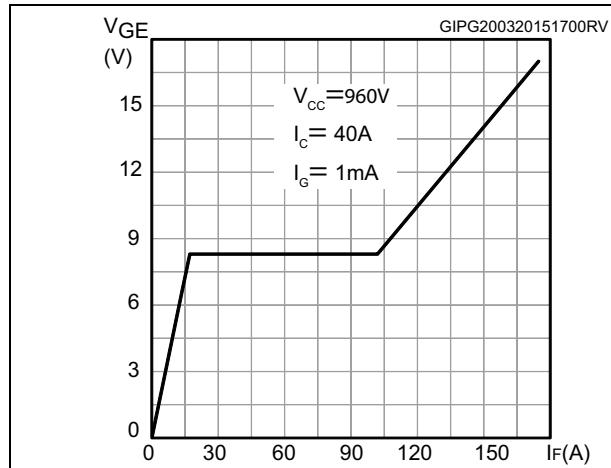
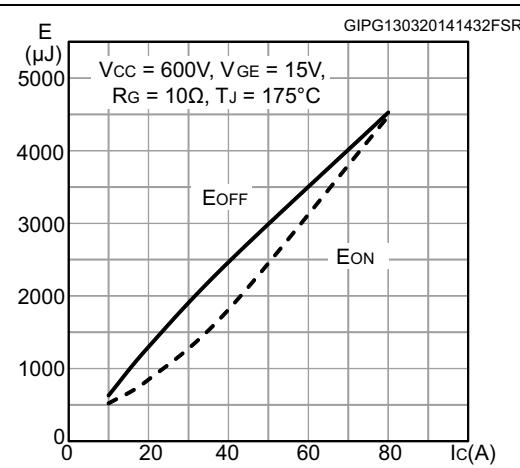
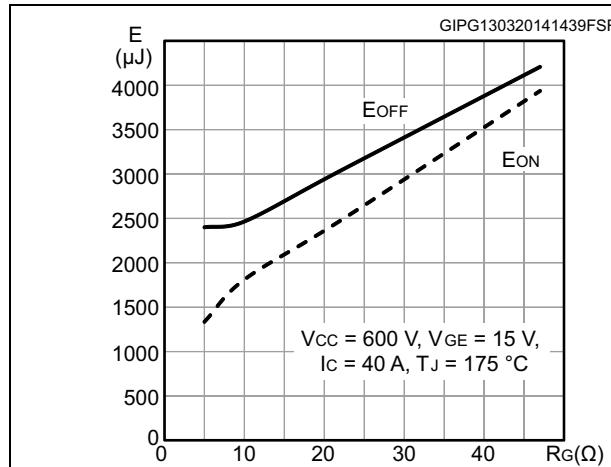
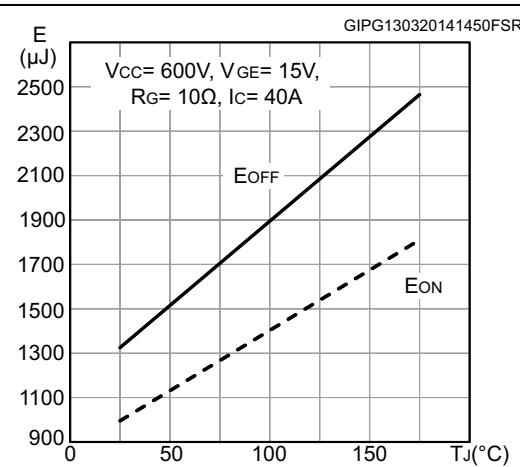
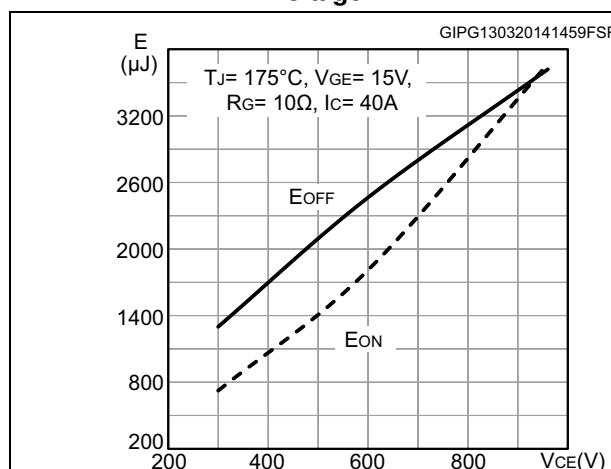
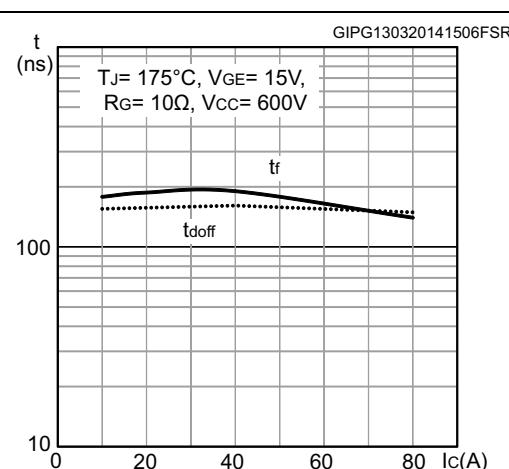
Figure 14. Gate charge vs. gate-emitter voltage**Figure 15. Switching loss vs collector current****Figure 16. Switching loss vs gate resistance****Figure 17. Switching loss vs temperature****Figure 18. Switching loss vs collector-emitter voltage****Figure 19. Switching times vs. collector current**

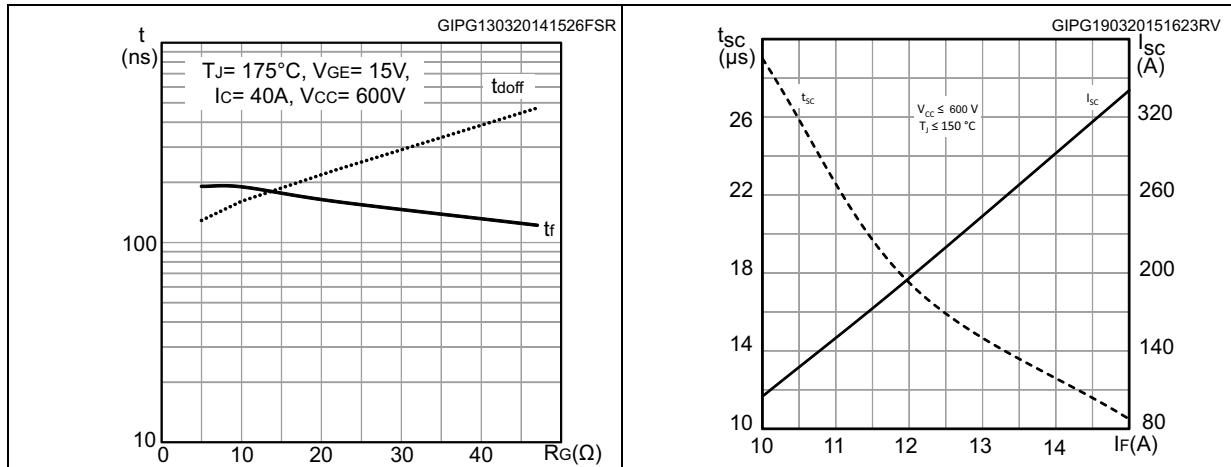
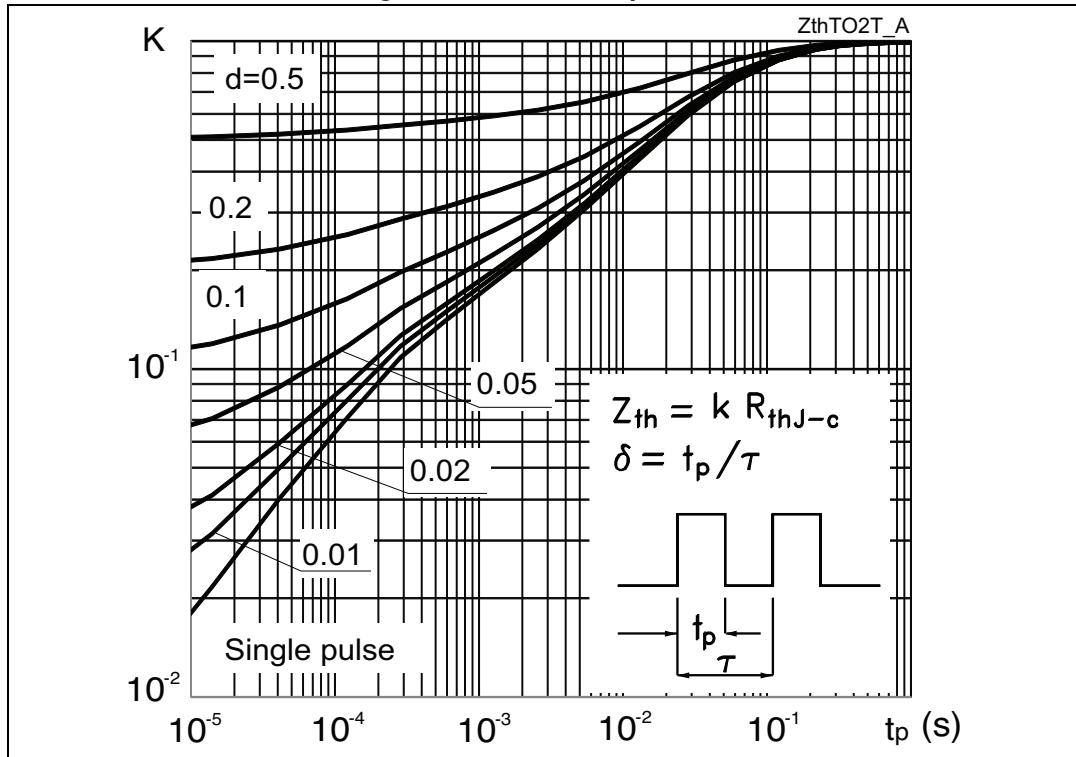
Figure 20. Switching times vs. gate resistance Figure 21. Short circuit time and current vs.VGE

Figure 22. Thermal impedance



3 Test circuits

Figure 23. Test circuit for inductive load switching

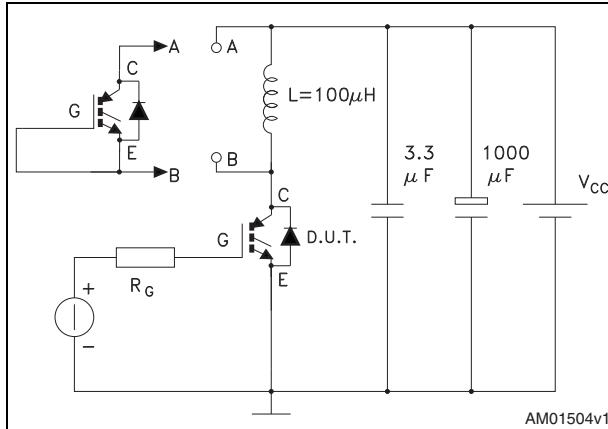


Figure 24. Gate charge test circuit

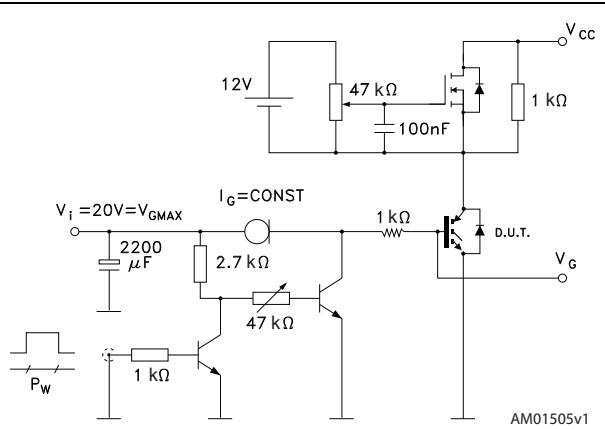
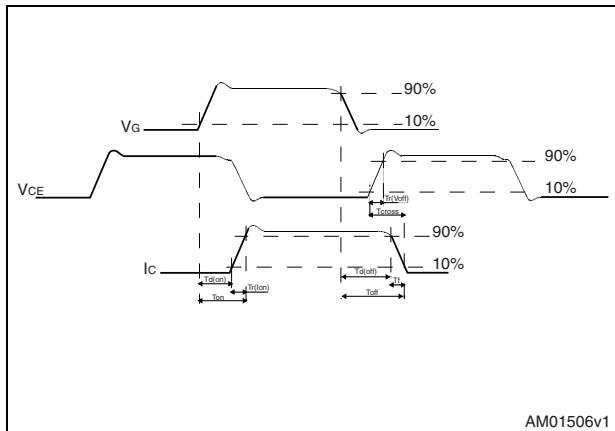


Figure 25. Switching waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com.
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4.1 TO-247, STGW40H120F2

Figure 26. TO-247 drawing

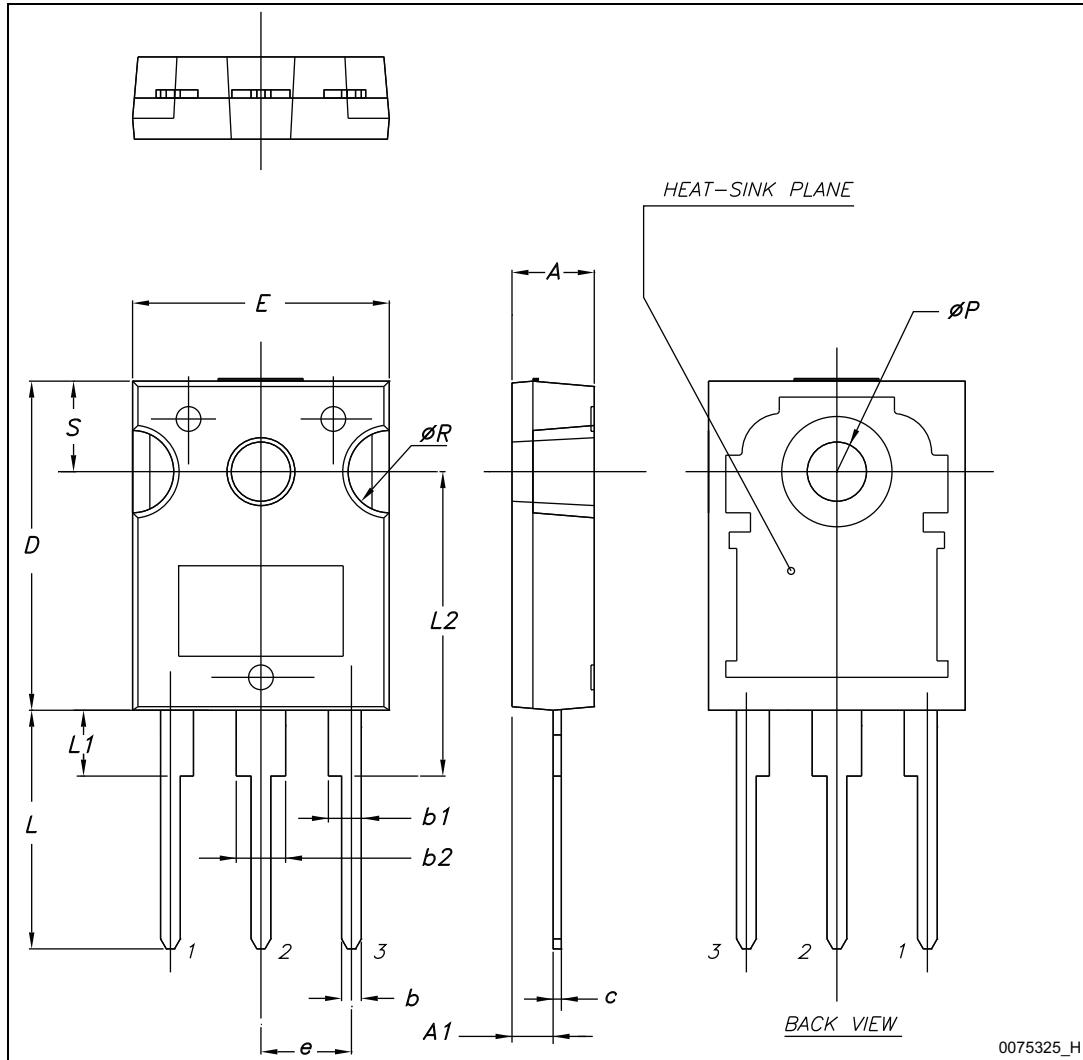


Table 7. TO-247 mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
c	0.40		0.80
D	19.85		20.15
E	15.45		15.75
e	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

4.2 TO-247 long leads, STGWA40H120F2

Figure 27. TO-247 long leads drawing

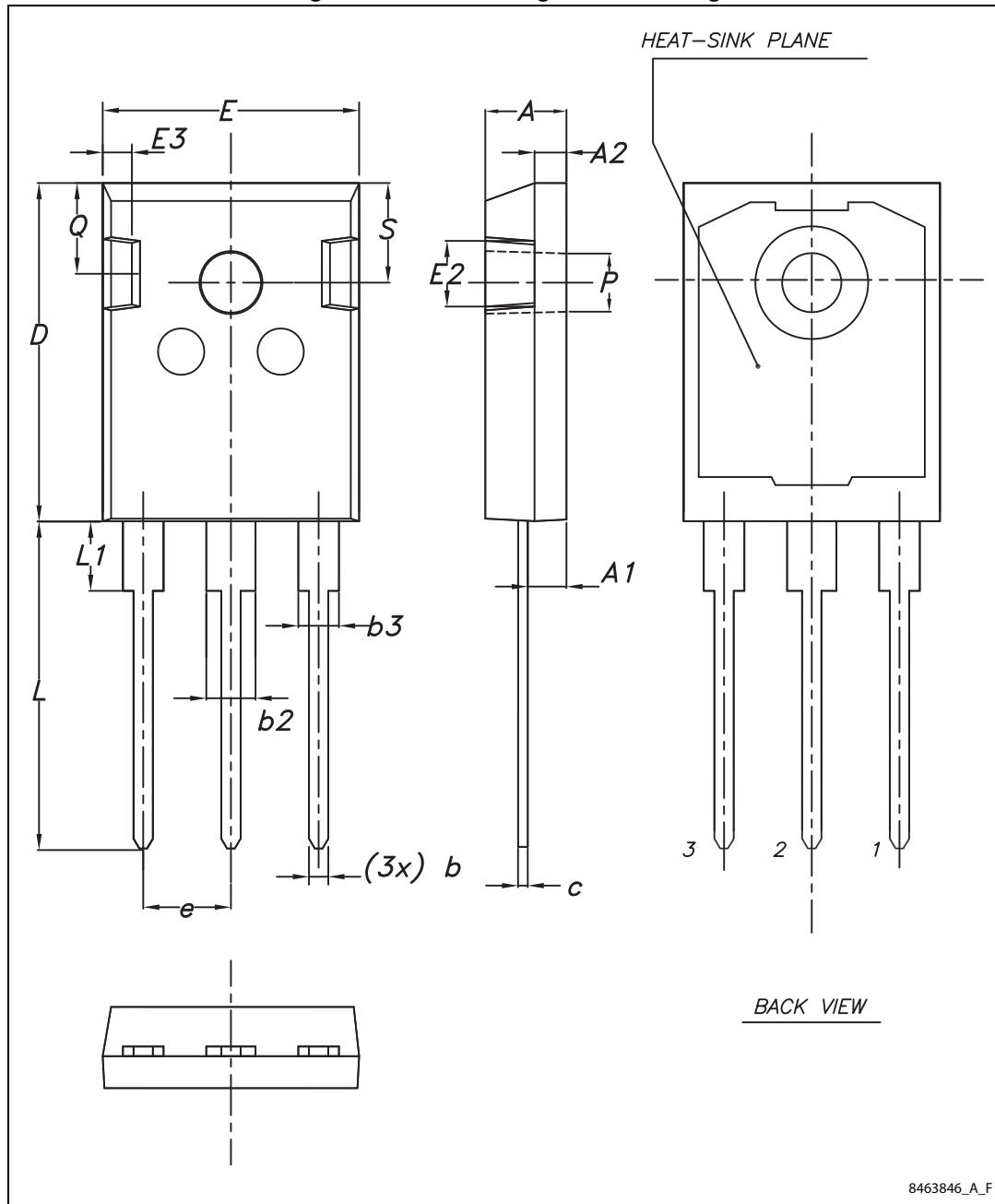


Table 8. TO-247 long leads mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.90	5.00	5.10
A1	2.31	2.41	2.51
A2	1.90	2.00	2.10
b	1.16		1.26
b2			3.25
b3			2.25
c	0.59		0.66
D	20.90	21.00	21.10
E	15.70	15.80	15.90
E2	4.90	5.00	5.10
E3	2.40	2.50	2.60
e	5.34	5.44	5.54
L	19.80	19.92	20.10
L1			4.30
P	3.50	3.60	3.70
Q	5.60		6.00
S	6.05	6.15	6.25

5 Revision history

Table 9. Document revision history

Date	Revision	Changes
29-Jan-2014	1	Initial release.
14-Mar-2014	2	Updated Table 4: Static characteristics and Table 5: Dynamic characteristics . Added Section 2.1: Electrical characteristics (curves) . Updated title in cover page. Minor text changes.
25-Mar-2015	3	Added 4.2: TO-247 long leads, STGWA40H120F2 Updated 4: Package mechanical data Minor text changes.

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